

**Scheme 1** PolyNPPBH/DNA was synthesized by oxidative polymerization of NPPBH monomer in presence of DNA molecules using  $\text{FeCl}_3$ .

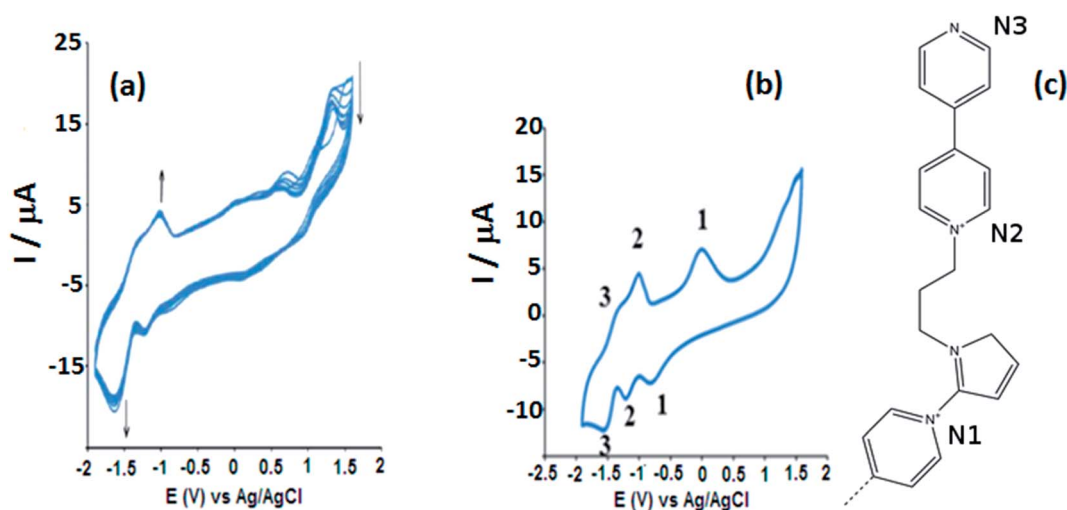
NPPBH serves as a metal-binding site. We prepared NPPBH by *N*-alkylation of pyrrole to form 1-(3-chloro-propyl)pyrrole followed by quaternization of the pyridyl group, of 4,4'-bipyridine (Scheme 1). The  $\text{PF}_6^-$  salt of NPPBH was precipitated as a brownish yellow powder in 33% overall yield. NPPBH monomer was characterized by  $^1\text{H}$  NMR, FTIR and mass spectroscopy (ESI $^\dagger$ ).

NPPBH was polymerized by both electrochemical and chemical methods. Electrochemical polymerisation involves the electrodeposition of the polymer on the anode of a standard 3-electrode cell. The chemical polymerization of NPPBH involves mixing a strong oxidizing agent, in this work  $\text{FeCl}_3$ , with the monomer solution. The electrochemical behavior of NPPBH was studied using cyclic voltammetry (Fig. 1). DNA-templated NPPBH nanowires (polyNPPBH/DNA) were chemically prepared by methods analogous to those used for simple poly(pyrrole)/DNA nanowires.<sup>21</sup>  $\text{Cu}^0$  nanoparticles were formed along the polyNPPBH/DNA nanowires by electroless reduction of  $\text{Cu}^{2+}$  with ascorbate.<sup>11</sup> FTIR spectroscopy showed that the

polyNPPBH/DNA nanowires consist of NPPBH intimately associated with the DNA; AFM of DNA-templated NPPBH showed relatively smooth and uniform nanowires and the optical spectroscopy of the Cu/polyNPPBH/DNA wires indicates the presence of metallic Cu *via* the plasmon absorption. Finally, the electronic conductivity of polyNPPBH/DNA and Cu/polyNPPBH/DNA were compared using scanned conductance (SCM) and conductive atomic force microscopy (cAFM).

### 3.1 Electrochemical polymerization of NPPBH

*N*-Substitution has a major influence on the electro-polymerization of pyrroles; the polymer yield and rate of polymerization decrease as the size of the alkyl group increases.<sup>19</sup> The electrode potential for the substituted monomers is usually higher than that of pyrrole which results in a lower polymerization rate.<sup>22,23</sup> The oxidation potential of the polymer is also increased: PPy oxidizes at  $-0.2$  V vs. aqueous SCE in MeCN, but *N*-alkyl substituted PPy films oxidize in the region  $+0.45$  to  $+0.64$  V.<sup>24</sup>



**Fig. 1** (a) Consecutive cyclic voltammograms for a platinum electrode in a solution containing 0.05 M of NPPBH and 50 mM  $\text{LiClO}_4/\text{MeCN}$  as electrolyte. The arrows indicate change of current with cycle number. (b) A single cyclic voltammogram of the polyNPPBH film that displays the peaks clearly. In both (a) & (b) the scan rate was  $100 \text{ mV s}^{-1}$  and the reference electrode was an aqueous  $\text{Ag}/\text{AgCl}$  electrode separated from the MeCN by a frit. 1, 2 and 3 refer to redox processes discussed in the text. (c) A portion of the polymer structure showing the three different types of pyridine-based nitrogen atoms N1–N3.











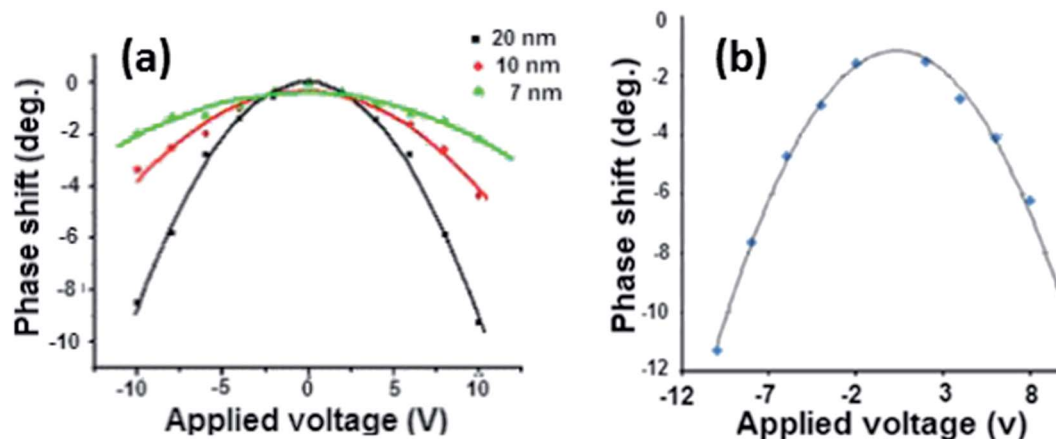


Fig. 8 (a) The phase shift of polyNPPBH/DNA nanowires as a function of applied tip bias voltage for different nanowires with different diameters. (b) The phase shift as a function of applied voltage for the Cu/polyNPPBH/DNA nanowire in Fig. 7b and c.

### 3.8 Electrical characterization of polyNPPBH/DNA and Cu/polyNPPBH/DNA using conductive atomic force microscopy

Conductive AFM measurements of nanowires were made using the procedure previously described.<sup>8</sup> In brief, a droplet of nanowires was allowed to dry on the substrate and individual nanowires are extended from the periphery of the dried material by surface forces. The tip makes contact to a single nanowire and the second (In/Ga) contact to complete the circuit is conveniently made to the mass of nanowires at the center of the dried droplet. The imaged area was about 1.0 mm away from the In/Ga eutectic contact. The mean diameter of the polyNPPBH/DNA nanowire in Fig. 9a was 15 nm. The closed loop system of the AFM instrument makes it possible to reproducibly position the cantilever at a point of interest on the nanowire and to record the current–voltage characteristic. The bias was swept from  $-5$  to  $+5$  V, while the deflection set-point was maintained at  $0.5$  V. The zero-bias resistance was extracted from each of these linear characteristics and is plotted in Fig. 9 against the distance between the point at which the tip contacted the single nanowire and the edge of

the main mass of nanowires. The same technique was applied to Cu/polyNPPBH/DNA nanowires.

The variation of resistance against relative distance,  $d$ , of a polyNPPBH/DNA and a Cu/polyNPPBH/DNA nanowire is shown in Fig. 9. The resistance increases with  $d$  because the current must flow through a longer portion of the nanowire. The contact resistance at either the In/Ga contact or at the tip/nanowire contact is roughly independent of this distance, as evidenced by the linear plots. The resistivity of the nanowires can then be obtained directly from the slope of the plots of Fig. 9 after multiplying by the area of cross-section of each wire obtained from the height and width in the AFM image. We obtain values of conductivity of  $0.42 \pm 0.019 \text{ S cm}^{-1}$  for the Cu/polyNPPBH/DNA nanowire and  $2.1 \pm 0.26 \times 10^{-2} \text{ S cm}^{-1}$  for the polyNPPBH/DNA nanowire.

The conductivities of the nanowires illustrate several aspects of the conduction mechanism in these structures. First, there is a substantial (20-fold) increase upon metallization of polyNPPBH/DNA to make Cu/polyNPPBH/DNA. This stands in contrast to the case of Pd on polyimidazole/DNA structures

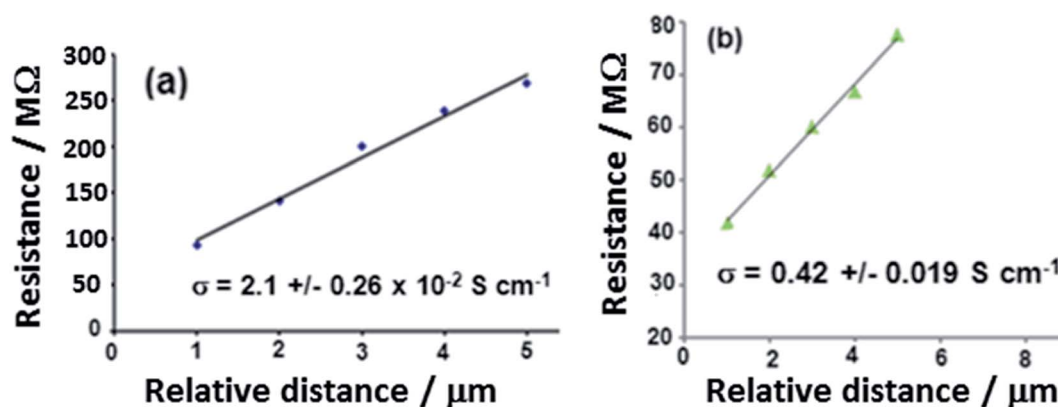


Fig. 9 (a) PolyNPPBH/DNA nanowire resistance as a function of tip-contact relative distance in c-AFM measurements; sample bias =  $7.0$  V at  $0.5$  deflection set point. (b) Cu/polyNPPBH/DNA nanowire resistance at zero bias as a function of tip-contact relative distance at  $0.5$  V deflection set point.





- 31 C. D. Wagner, W. M. Riggs, L. E. Davis and J. F. Moulder, *Handbook of X-Ray Photoelectron Spectroscopy*, Perkin-Elmer, Ramsey, MN, 1979.
- 32 J. C. Fuggle, E. Kallne, L. M. Watson and D. J. Fabian, *Phys. Rev. B: Condens. Matter Mater. Phys.*, 1977, **16**, 750–761.
- 33 S. Ptasinska, A. Stypczynska, T. Nixon, N. J. Mason, D. V. Klyachko and L. Sanche, *J. Chem. Phys.*, 2008, **129**, 065102.
- 34 S. M. D. Watson, M. A. Galindo, B. R. Horrocks and A. Houlton, *J. Am. Chem. Soc.*, 2014, **36**, 6649–6655.
- 35 L. Dong, T. Hollis, S. Fishwick, B. A. Connolly, N. G. Wright, B. R. Horrocks and A. Houlton, *Chem.–Eur. J.*, 2007, **13**, 822–828.
- 36 C. Staii, A. T. Johnson and N. J. Pinto, *Nano Lett.*, 2004, **4**(5), 859–862.
- 37 T. S. Jespersen and J. Nygard, *Nano Lett.*, 2005, **5**(9), 1838–1841.
- 38 M. Bockrath, N. Markovic, A. Shepard, M. Tinkham, L. Gurevich, L. P. Kouwenhoven, M. W. Wu and L. L. Sohn, *Nano Lett.*, 2002, **2**, 187–190.
- 39 L. Dong, T. Hollis, S. Fishwick, B. A. Connolly, N. G. Wright, B. R. Horrocks and A. Houlton, *Chem.–Eur. J.*, 2007, **13**, 822–828.
- 40 R. Matula, *J. Phys. Chem. Ref. Data*, 1979, **8**(4), 1147–1298.
- 41 P. Sheng, B. Abeles and Y. Arie, *Phys. Rev. Lett.*, 1973, **31**, 44–47.

